

Application/Control No.	Applicant(s)/Patent under Reexamination	
08/823,980	WEINER ET AL.	
Examiner	Art Unit	
Ron Schwadron, Ph.D.	1644	

SEARCHED					
Class	Subclass	Date	Examiner		
424	\94.\ \46.11 \9a.1	3/	R		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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SEQ ID NO: 8 (See Scope) Part of Paper No. 200703